Description

The AEM00940 mini evaluation board is a printed circuit board (PCB) featuring all the needed components to operate the AEM00940 integrated circuit (IC). Please refer to the datasheet for all the useful details about the AEM00940 (Document DS_AEM00940).

The AEM00940 mini evaluation board allows users to test the e-peas IC and analyze its performances in a laboratory-like setting.

It allows easy connections to the energy harvester, the storage element, the low-voltage and the high-voltage loads. It also provides all the configuration access to set the device in any one of the modes described in the datasheet. The control and status signals are available on external pins, allowing users to wire for any usage scenario and evaluate the relevant performance.

The AEM00940 mini evaluation board is a plug and play, intuitive and efficient tool for making the appropriate decisions (component selection, operating modes...) for the design of a highly efficient subsystem powered by energy harvesting in your target application.

Appearance

Features

Solder pads
- Ground connection.
- Source of energy (harvester).
- Access to two status signals.
- Access to the constant voltage harvesting node.
- Primary energy storage element.
- Energy storage element (Battery or (super) capacitor).
- Balancing for dual cell capacitor.
- High-voltage load.
- Low-voltage load.

Provision for resistors
- Custom mode configuration.
- Primary battery configuration.
- Dual-cell supercapacitor configuration.
- Low drop-out regulators (LDOs) enabling.
- Energy storage elements and LDOs configuration.
- Constant voltage harvesting configuration.

EvB Information

<table>
<thead>
<tr>
<th>Part Number</th>
<th>Dimensions</th>
</tr>
</thead>
<tbody>
<tr>
<td>2EAEM00940C0012</td>
<td>28 mm x 28 mm</td>
</tr>
</tbody>
</table>

Device Information

<table>
<thead>
<tr>
<th>Part Number</th>
<th>Dimensions</th>
</tr>
</thead>
<tbody>
<tr>
<td>10AEM00940C0000</td>
<td>5 mm x 5 mm</td>
</tr>
</tbody>
</table>
1. Connections Diagram

**Figure 1: Connection Diagram**

**NOTE:** if R1, R2, R3, R4 and R25 are not mounted (and thus SET_OVDIS, SET_OVCH and SET_CHRDY are floating), make sure that no power source is connected to SRC or to PRIM when CFG[2:0] is LLL (custom mode) or floating. This would lead to damaging the AEM00940. Having SET_OVDIS, SET_OVCH and SET_CHRDY tied to BUCK by installing 0 Ω on R2, R3 and R25 prevents this behavior.
# 1.1. Signals Description

<table>
<thead>
<tr>
<th>NAME</th>
<th>FUNCTION</th>
<th>CONNECTION</th>
<th>If not used</th>
<th>If used</th>
</tr>
</thead>
<tbody>
<tr>
<td><strong>Power signals</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>SRC</td>
<td>Connection to the harvested energy source.</td>
<td>Connect the source element.</td>
<td></td>
<td></td>
</tr>
<tr>
<td>BATT</td>
<td>Connection to the energy storage element.</td>
<td>Connect the storage element in addition to CBATT(^a) (min 150 µF).</td>
<td>Do not remove CBATT.</td>
<td></td>
</tr>
<tr>
<td>BAL</td>
<td>Connection to mid-point of a dual-cell</td>
<td>Connect mid-point of supercapacitor and remove 0 Ω resistor on R30.</td>
<td>Use a 0 Ω resistor on R30.</td>
<td></td>
</tr>
<tr>
<td></td>
<td>supercapacitor.</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>PRIM</td>
<td>Connection to the primary battery.</td>
<td>Connect primary battery and remove 0 Ω resistor R26.</td>
<td>Connect a 0 Ω resistor R26.</td>
<td></td>
</tr>
<tr>
<td>LVOUT</td>
<td>Output of the low-voltage LDO regulator.</td>
<td>Connect a load.</td>
<td>Leave floating</td>
<td></td>
</tr>
<tr>
<td>HVOUT</td>
<td>Output of the high-voltage LDO regulator.</td>
<td>Connect a load.</td>
<td>Leave floating</td>
<td></td>
</tr>
<tr>
<td><strong>Configuration signals</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>CFG[2:0]</td>
<td>Configuration of the threshold voltages for</td>
<td>Connect 0 Ω resistors (see Table 2).</td>
<td>Cannot be left floating (see Table 2).</td>
<td></td>
</tr>
<tr>
<td></td>
<td>the energy storage element.</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>SRC_LVL_RANGE[1:0]</td>
<td>Constant voltage harvesting range multiplier.</td>
<td>Connect 0 Ω resistors (see Table 4).</td>
<td>Cannot be left floating (see Table 4).</td>
<td></td>
</tr>
<tr>
<td>SRC_LVL_D</td>
<td>Constant voltage harvesting range.</td>
<td>Solder SMD resistors on R9-R10 footprints.</td>
<td>Cannot be left floating (see Section 2.3.2).</td>
<td></td>
</tr>
<tr>
<td>SRC_LVL_U</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>FB_PRIM_D</td>
<td>Configuration of the primary battery.</td>
<td>Use resistors R7-R8 (see Section 2.3.3).</td>
<td>Connect a 0 Ω resistor R26.</td>
<td></td>
</tr>
<tr>
<td>FB_PRIM_U</td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>FB_HV</td>
<td>Configuration of the high-voltage LDO in the</td>
<td>Use resistor R5-R6 (see Section 2.3.1).</td>
<td>Leave floating</td>
<td></td>
</tr>
<tr>
<td></td>
<td>custom mode.</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td><strong>Control signals</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>ENHV</td>
<td>Enabling pin for the high-voltage LDO.</td>
<td>Connect 0 Ω resistor (see Table 3).</td>
<td>Cannot be left floating (see Table 3).</td>
<td></td>
</tr>
<tr>
<td>ENLV</td>
<td>Enabling pin for the low-voltage LDO.</td>
<td>Connect 0 Ω resistor (see Table 3).</td>
<td>Cannot be left floating (see Table 3).</td>
<td></td>
</tr>
<tr>
<td><strong>Status signals</strong></td>
<td></td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>STATUS[1]</td>
<td>Logic output. Asserted if the battery voltage</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>falls under Vovdis or if the AEM is taking</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>energy from the primary battery.</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td>STATUS[0]</td>
<td>Logic output. Asserted when the LDOs can be</td>
<td></td>
<td></td>
<td></td>
</tr>
<tr>
<td></td>
<td>enabled.</td>
<td></td>
<td></td>
<td></td>
</tr>
</tbody>
</table>

\(a\) CBATT capacity on the EvK may vary depending on suppliers availability, with a minimum value of 150µF.
2. General Considerations

2.1. Safety Information

Always connect the elements in the following order:

1. Reset the board - see “How to reset the AEM00940 evaluation board” on Figure 2.
2. Completely configure the PCB (resistors):
   - Source level configuration (SRC_LVL_RANGE[1:0]) - Table 4.
   - Battery and LDOs configuration (CFG[2:0] and, if needed, R1 to R6) - see Table 2.
   - Primary battery configuration (R26 or R7-R8) - see Section 2.3.3.
   - LDOs enabling (ENHV and ENLV) - see Table 3.
   - Balancing circuit connection (BAL) - see Section 2.3.4.
3. Connect the storage elements on BATT and optionally the primary battery on PRIM.
4. Connect the high and/or low voltage loads on HVOUT/LVOUT (optional).
5. Connect the source on SRC.

To avoid damage to the board, users are urged to follow this procedure.

How to reset the AEM00940 evaluation board:

To reset the board, simply disconnect the storage element and the optional primary battery and connect the reset pads to GND in order to discharge the internal nodes of the system.

<table>
<thead>
<tr>
<th>Configuration pins</th>
<th>Storage element threshold voltages</th>
<th>LDOs output voltages</th>
<th>Typical use</th>
</tr>
</thead>
<tbody>
<tr>
<td>H</td>
<td>H</td>
<td>H</td>
<td>4.12 V</td>
</tr>
<tr>
<td>H</td>
<td>H</td>
<td>L</td>
<td>4.12 V</td>
</tr>
<tr>
<td>H</td>
<td>L</td>
<td>H</td>
<td>4.12 V</td>
</tr>
<tr>
<td>H</td>
<td>L</td>
<td>L</td>
<td>2.70 V</td>
</tr>
<tr>
<td>L</td>
<td>H</td>
<td>H</td>
<td>4.50 V</td>
</tr>
<tr>
<td>L</td>
<td>H</td>
<td>L</td>
<td>4.50 V</td>
</tr>
<tr>
<td>L</td>
<td>L</td>
<td>H</td>
<td>3.63 V</td>
</tr>
<tr>
<td>L</td>
<td>L</td>
<td>L</td>
<td>Custom mode - see Section 2.3.1.</td>
</tr>
</tbody>
</table>
2.3. Advanced Configurations

A complete description of the system constraints and configurations is available in the AEM00940 datasheet “System configuration” Section.

A reminder on how to calculate the configuration resistors value is provided below. Calculation can be made with the help of the spreadsheet found on e-peas website.

2.3.1. Custom Mode

In addition to the pre-defined storage element protection levels, the custom mode allows users to define their own levels via resistors R1 to R4 and to tune the output of the high voltage LDO HVOUT via resistors R5-R6.

Here is how to determine the values of R1-R4 to set the desired storage element protection levels:

- \( R_T = R_1 + R_2 + R_3 + R_4 \)
- \( 1\,\text{M}\Omega \leq R_T \leq 100\text{M}\Omega \)
- \( R_1 = R_T \cdot \frac{1\text{V}}{V_{OCH}} \)
- \( R_2 = R_T \cdot \left( \frac{1\text{V}}{V_{CHRDY}} - \frac{1\text{V}}{V_{OCH}} \right) \)
- \( R_3 = R_T \cdot \left( \frac{1\text{V}}{V_{OVDIS}} + \frac{1\text{V}}{V_{CHRDY}} \right) \)
- \( R_4 = R_T \cdot \frac{1}{V_{OVDIS}} \)

Here is how to determine the values of R5-R6 to set the desired HVOUT voltages:

- \( R_V = R_5 + R_6 \)
- \( 1\,\text{M}\Omega \leq R_V \leq 40\text{M}\Omega \)
- \( R_5 = R_V \cdot \frac{1\text{V}}{V_H} \)
- \( R_6 = R_V \cdot \left( 1 - \frac{1\text{V}}{V_H} \right) \)

Make sure the protection levels satisfy the following conditions:
- \( V_{CHRDY} + 0.05\text{V} \leq V_{OCH} \leq 4.5\text{V} \)
- \( V_{OVDIS} + 0.05\text{V} \leq V_{CHRDY} \leq V_{OCH} - 0.5\text{V} \)
- \( 2.2\text{V} \leq V_{OVDIS} \)
- \( V_H \leq V_{OVDIS} - 0.3\text{V} \)

If custom mode used:
- Remove R2, R3 and R25 zero ohm resistors.
- Set resistors R1 to R6 to configure the custom mode.

If custom mode unused:
- Leave the resistor footprints of R1 to R6 empty.
- Place 0 ohm resistors on R25.
- Do not set CFG[2:0] to LLL.

2.3.2. Constant Voltage Configuration

The regulated harvesting voltage \( V_{SRC,REG} \) can be defined by the use of the resistors R9 and R10.

\( SRC_LVL_RANGE[1:0] \) must be set according to the range of \( V_{SRC,REG} \) as shown in Table 4 by using the following formulas:

- \( R_S = R_9 + R_10 \)
- \( 100\text{k}\Omega \leq R_S \leq 1\text{M}\Omega \)
- \( R_9 = \frac{V_{SRC,REG}}{\text{Gain}} \cdot \frac{1}{2.2\text{V}} \)
- \( R_10 = R_S - R_9 \)

R9 and R10 must either be set by soldering SMD resistors on the R9-R10 footprints.

2.3.3. Primary Battery Configuration

If a primary storage is used, it is mandatory to determine \( V_{PRIM,MIN} \), the voltage at which the primary battery is considered fully depleted. To do so, use resistors R7 - R8.

These resistors are calculated as follows:

- \( R_P = R_7 + R_8 \)
- \( 100\text{k}\Omega \leq R_P \leq 500\text{k}\Omega \)
- \( R_7 = \frac{V_{PRIM,MIN}}{4} \cdot \frac{1}{2.2\text{V}} \)
- \( R_8 = R_P - R_7 \)
If unused, use a 0Ω resistor on R26.

2.3.4. Balancing Circuit Configuration

When using a dual-cell supercapacitor (that does not already include a balancing circuit), enable the balancing circuit configuration to ensure equal voltage on both cells. To do so:

- Connect the node between the two supercapacitor cells to BAL (on BATT connector).
- Make sure the 0 Ω resistor R30 is removed.

If unused, connect a 0 Ω resistor on R30.
3. Functional Tests

This section presents a few simple tests that allow the user to understand the functional behavior of the AEM00940. To avoid damaging the board, follow the procedure found in Section 2.1 “Safety Information”. If a test has to be restarted make sure to properly reset the system to obtain reproducible results.

Those functional tests were made using the following setup:

- Configurations:
  - SRC_LVL_RANGE[1:0] = LL
  - CFG[2:0] = HLL, ENHV = H, ENLV = H.
- Storage element: Capacitor (4.7 mF + CBATT).
- Loads: 10 kΩ on HVOUT. LVOUT left floating.
- SRC: current source (1 mA or 100 µA) with voltage compliance (4V).

Feel free to adapt the setup to match your system as long as the input and cold-start constraints are respected (see the AEM00940 datasheet “Introduction” Section).

3.1. Start-up

The following example allows users to observe the behavior of the AEM00940 in the wake-up mode.

**Setup**

- Place the probes on the nodes to be observed.
- Referring to Figure 1, follow steps 1 to 5 explained in Section 2.1 “Safety Information”.

**Observations and Measurements**

- **BATT**: Voltage rises as the power provided by the source is transferred to the storage element (see Figure 3).
- **SRC**: Regulated at VSRC_REG.
- **HVOUT/LVOUT**: Regulated when voltage on BATT first rises above VCHRDY (see Figure 3).
- **STATUS[0]**: Asserted when the LDOs are ready to be enabled (refer to the AEM00940 datasheet “Normal Mode” section) (see Figure 3).

3.2. Shutdown

This test allows users to observe the behavior of the AEM00940 when the system is running out of energy.

**Setup**

- Place the probes on the nodes to be observed.
- Referring to Figure 1, follow steps 1 to 5 explained in Section 2.1 “Safety Information”. Configure the board in the desired state and start the system (see Section 3.1). Do not use a primary battery.
- Let the system reach a steady state (i.e. voltage on BATT between VCHRDY and VOVCH and STATUS[0] asserted).
- Remove the PV cell and let the system discharge through quiescent current and HVOUT/LVOUT load(s).

**Observations and Measurements**

- **BATT**: Voltage decreases as the system consumes the power accumulated in the storage element. The voltage remains stable after crossing VOVDIS (see Figure 4).
- **STATUS[0]**: De-asserted when the LDOs are no longer available as the storage element is running out of energy. This happens 600 ms after STATUS[1] assertion (see Figure 4).
- **STATUS[1]**: Asserted for 600 ms when the storage element voltage (BATT) falls below VOVDIS (see Figure 4).
3.3. Switching on Primary Battery

This example allows users to observe switching from the main storage element to the primary battery when the system is running out of energy.

Setup
- Place the probes on the nodes to be observed.
- Referring to Figure 1, follow steps 1 to 5 explained in Section 2.1 “Safety Information”. Configure the board in the desired state and start the system (see Section 3.1). Connect a primary battery (example: 3.1 V coin cell with protection level at 2.4 V, R7 = 68 kΩ and R8 = 180 kΩ).
- Let the system reach a steady state (i.e. voltage on BATT between VCHRDY and VOVDIS and STATUS[0] asserted).
- Remove the PV cell and let the system discharge through quiescent current and HVOUT/LVOUT load(s).

Observations and Measurements
- BATT: Voltage decreases as the system consumes the power accumulated in the storage element. The voltage reaches VOVDIS and than rises again to VCHRDY as it is recharged from the primary battery (see Figure 5).
- STATUS[0]: Never de-asserted as the LDOs are still functional (see Figure 5).
- HVOUT: Stable and not affected by switching on the primary battery (see Figure 5).

3.4. Cold Start

The following test allows the user to observe the minimum voltage required to coldstart the AEM00940. To prevent leakage current induced by the probe, the user should avoid probing any unnecessary node. Make sure to properly reset the board to observe the cold-start behavior.

Setup
- Place the probes on the nodes to be observed.
- Referring Figure 1, follow steps 1 and 2 explained in Section 2.1. Configure the board in the desired state. Do not plug any storage element in addition to CBATT.
- SRC: Connect your source element.

Observations and Measurements
- SRC: Equal to the cold-start voltage during the cold-start phase. Regulated at the selected voltage when cold start is over. (See Figure 6). Be careful that the cold-start phase time will shorten with the input power. Limit it to ease the observation.
- BATT: Starts to charge when the cold-start phase is over (see Figure 6).
3.5. Dual-cell Supercapacitor Balancing Circuit

The following test allows the user to observe the balancing circuit behavior that balances the voltage on both side of the BAL pin.

Setup

- Following steps 1 and 2 explained in Section 2.1 and referring to Figure 1, configure the board in the desired state. Remove the 0 Ω resistor on R30.

- **BATT**: Plug a capacitor C1 between the positive (+) pin and the BAL pin, and a capacitor C2 between the BAL pin and the negative (-) pin.
  - C1 & C2 > 1 mF.
  - \((C2 \times V_{CHRDY}) / C1 \geq 0.9\) V.

- **SRC**: Connect your source element to power up the system.

Observations and Measurements

- **BAL** voltage equals half of the **BATT** voltage.
4. Performance Tests

This section presents the tests to reproduce the performance graphs found in the AEM00940 datasheet and to understand the functionalities of the AEM00940. To be able to reproduce those tests, the following equipment is required:

- 1 voltage source.
- 2 source measure units (SMUs).
- 1 oscilloscope.

To avoid damaging the board, follow the procedure in Section 2.1 "Safety Information". If a test has to be restarted, make sure to properly reset the system to obtain reproducible results (see “How to reset the AEM00940 evaluation board” in Section 2.1).

4.1. LDOs

The following example instructs users on how to measure the output voltage stability of the LDOs (Low-voltage and High-voltage LDO regulation Sections of the AEM00940 datasheet).

Setup

- Referring to Figure 1, follow steps 1 and 2 explained in the Section 2.1. Configure the board in the desired state and connect your storage element(s).
- VBOOST: Connect SMU1. Configure it to Voltage Source with a Current Compliance of 200 mA.
- HVOUT / LVOUT: Connect SMU2 to the LDO you want to measure. Configure it to sink current with a Voltage Compliance of 5 V for HVOUT or 2.5 V for LVOUT.

Manipulations

- Impose a voltage between $V_{OVCH}$ and 5 V on SMU1 to force the AEM to start.
- Sweep voltage on SMU1 from $V_{VDIS} + 50$ mV to 4.5 V.
- Repeat with different current levels on SMU2 (from 10 µA to 80 mA for HVOUT and from 10 µA to 20 mA for LVOUT). Please make sure to set negative current values on SMU2 to simulate the load.

Measurements

- HVOUT/LVOUT: Measure the voltage.

4.2. BOOST Efficiency

This test allows users to reproduce the efficiency graphs of the AEM00940 boost converter (Boost Conversion Efficiency Sections of the AEM00940 datasheet).

Setup

- Following steps 1 and 2 explained in the Section 2.1 and referring to Figure 1, configure the board in the desired state.
- VBUCK: Connect a 2.3 V Voltage Source to prevent VBUCK to sink current from VBOOST.
- SRC: Connect SMU1. Configure it to Current Source with a Voltage Compliance of 0 V.
- VBOOST: Connect SMU2 and configure it to Voltage Source with a Current Compliance of 200 mA.

Warning regarding measurements:

Any item connected to the PCB (load, probe, storage device, etc.) involves a leakage current. This can negatively impact the measurements. Whenever possible, disconnect unused items to limit this effect.

![Figure 7: HVOUT at 3.3 V and 2.5 V](image)

![Figure 8: LVOUT at 1.2 V and 1.8 V](image)
4.3. Custom Mode Configuration

This test allows users to measure the custom protection levels of the storage element set by resistors R1 to R6.

Setup
- Referring to Section 1, follow steps 1 and 2 explained in Section 2.1.
- To select custom mode:
  - Set CFG[2:0] = LLL.
  - Remove R2, R3 and R25.
  - Choose R1 to R6 to configure the battery protection levels and HVOUT output voltage.
- Place the probes on the nodes to be observed.
- SRC: connect your source element to power up the system.

Manipulations
- Remove the source element after the voltage on BATT has reached steady state (between VCHRDY and VOVCH).

Measurements
- Measure the following nodes to ensure the correct behavior of the AEM00940 with respect to the custom configuration:
  - STATUS[0]: Asserted when the LDOs can be enabled (i.e. when BATT first rises above VCHRDY).
  - STATUS[1]: Asserted when BATT falls below VOVDIS.
  - BATT: Rise up and oscillate around VOVCH as long as the source element has not been removed.
  - HVOUT: Equal to the value set by R5-R6.
5. Schematic
### 6. Revision History

<table>
<thead>
<tr>
<th>EVK Version</th>
<th>User Guide Revision</th>
<th>Date</th>
<th>Description</th>
</tr>
</thead>
<tbody>
<tr>
<td>1.2</td>
<td>1.0</td>
<td>August, 2023</td>
<td>Creation of the document</td>
</tr>
</tbody>
</table>

Table 5: Revision history